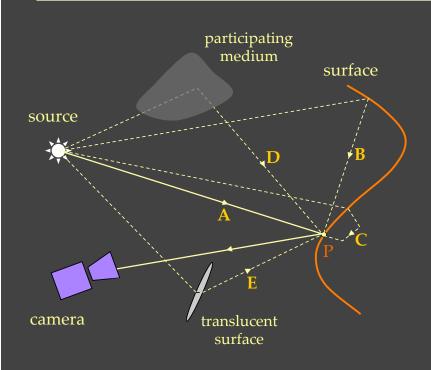
# Fast Separation of Direct and Global Images Using High Frequency Illumination

Shree K. Nayar
Gurunandan G. Krishnan
Columbia University
Michael D. Grossberg
City College of New York
Ramesh Raskar
MERL

SIGGRAPH Conference Boston, July 2006

Support: ONR, NSF, MERL

#### Direct and Global Illumination





A: Direct

B: Interrelection

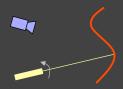
C : Subsurface

D: Volumetric

E: Diffusion

#### Related Work

• Inverse Light Transport (Seitz et. al., ICCV 05)



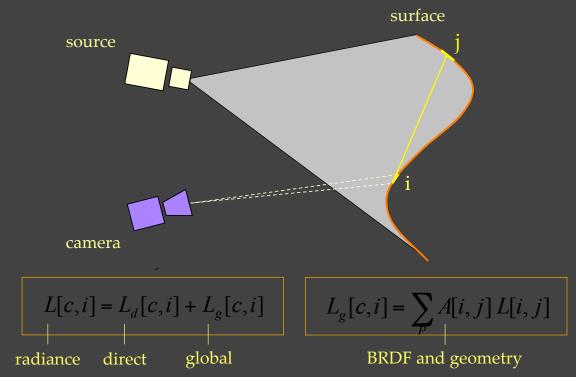
• Dual Photography (Sen et. al., Siggraph 05)

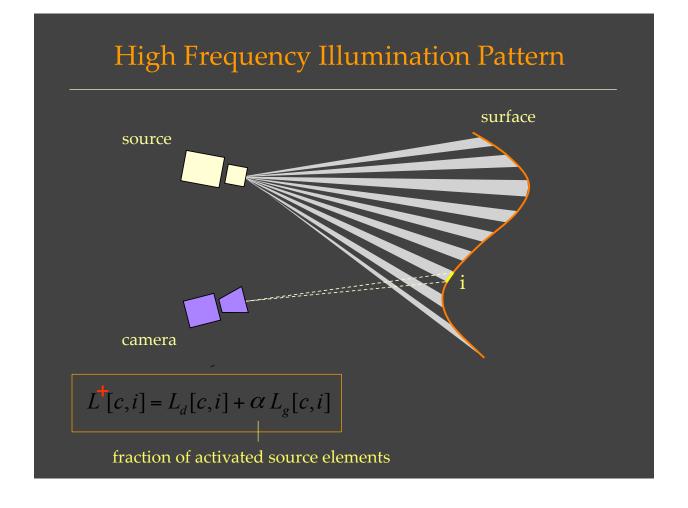


#### Fast Separation of Direct and Global Images

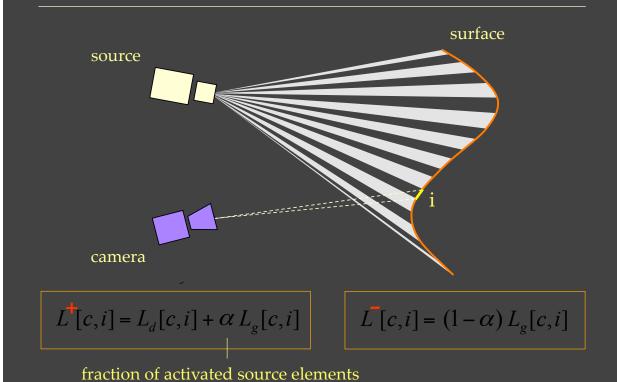
- Create Novel Images of the Scene
- Enhance Brightness Based Vision Methods
- New Insights into Material Properties

# Direct and Global Components: Interreflections





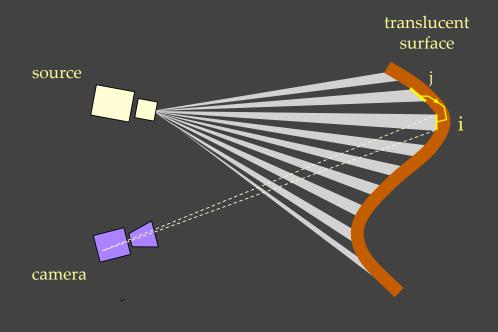




#### Separation from Two Images

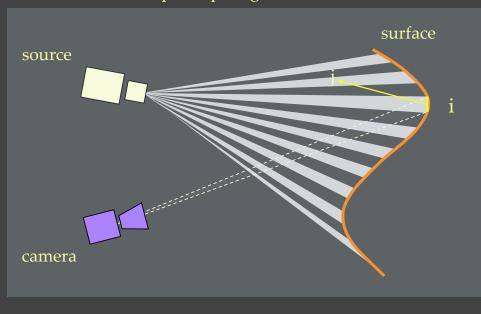
$$\alpha = \frac{1}{2}$$
:  $L_d = L_{\text{max}} - L_{\text{min}}$ ,  $L_g = 2L_{\text{min}}$  direct global

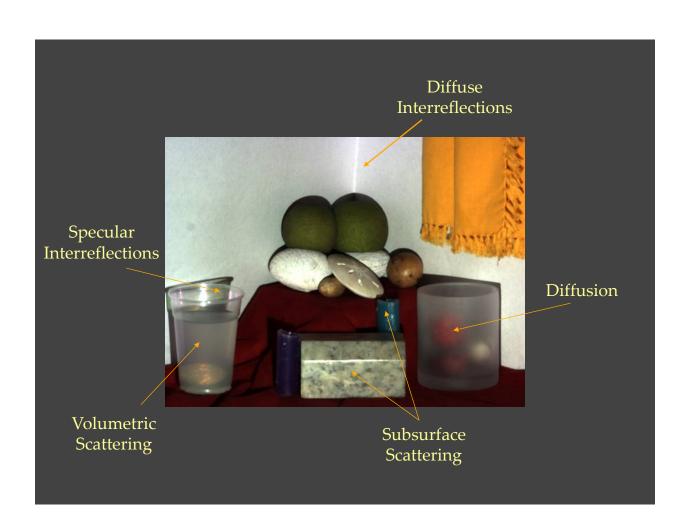
### Other Global Effects: Subsurface Scattering



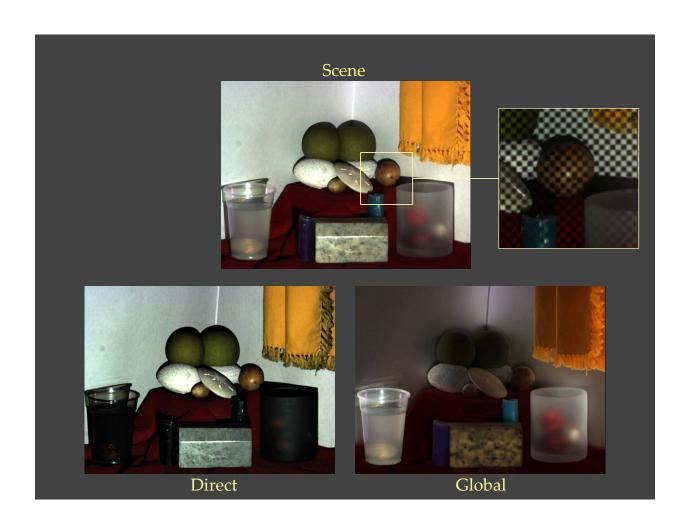
#### Other Global Effects: Volumetric Scattering

#### participating medium









## Real World Examples:

Can You Guess the Images?









Direct

Global

# Wooden Blocks: Specular Interreflections



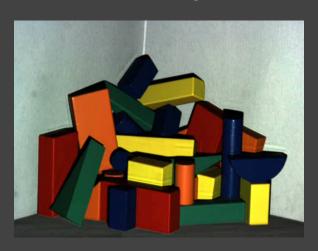






Global

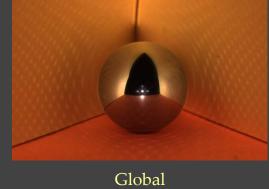
#### Novel Images



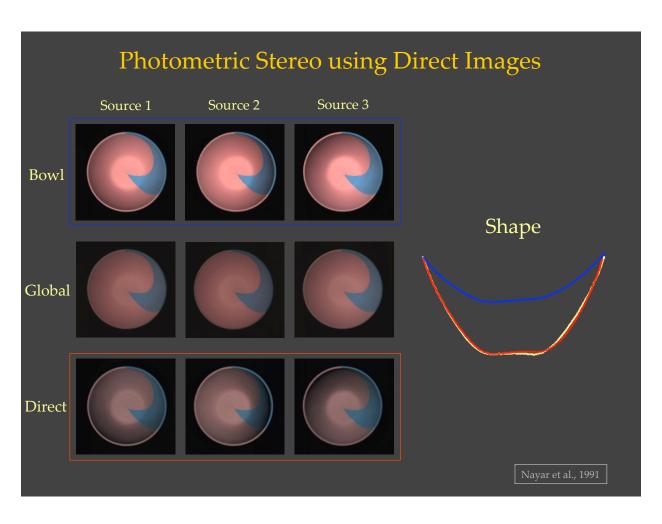
# Mirror Ball: Failure Case



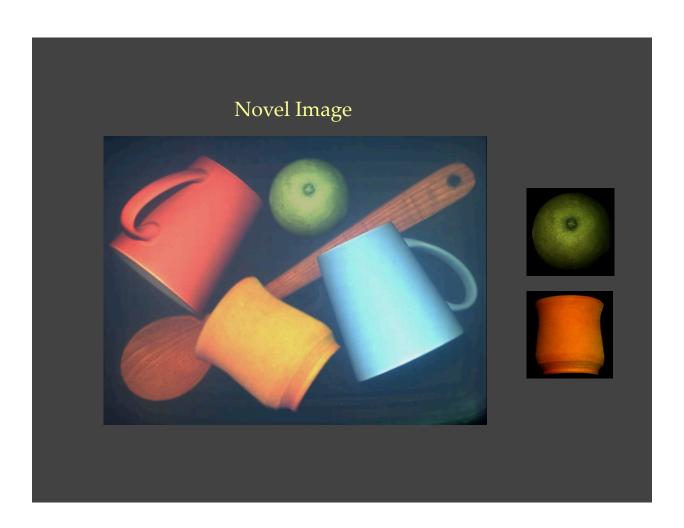


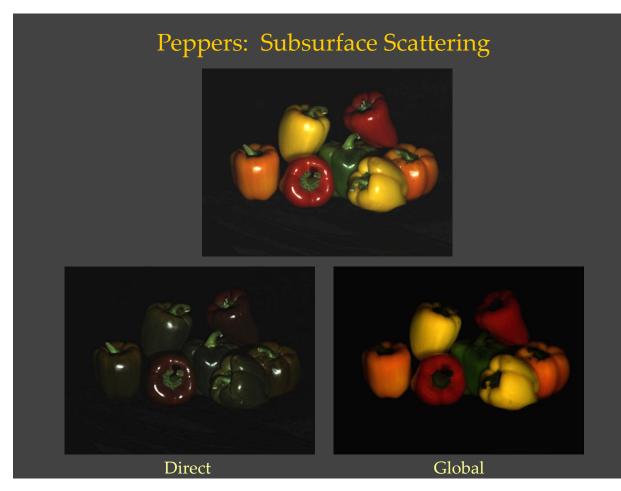


Direct









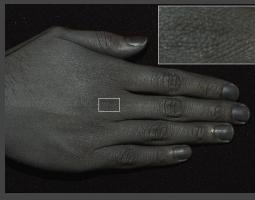
#### Novel Images



### Hand



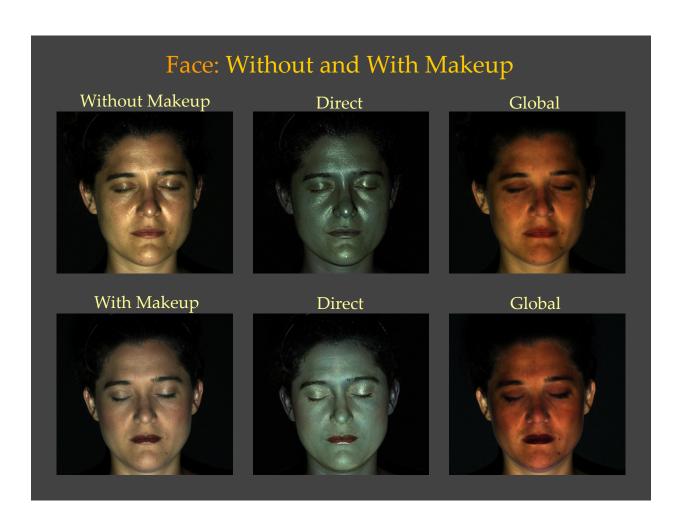
**Skin:** Hanrahan and Krueger 93, Uchida 96, Haro 01, Jensen et al. 01 Cula and Dana 02, Igarashi et al. 05, Weyrich et al. 05

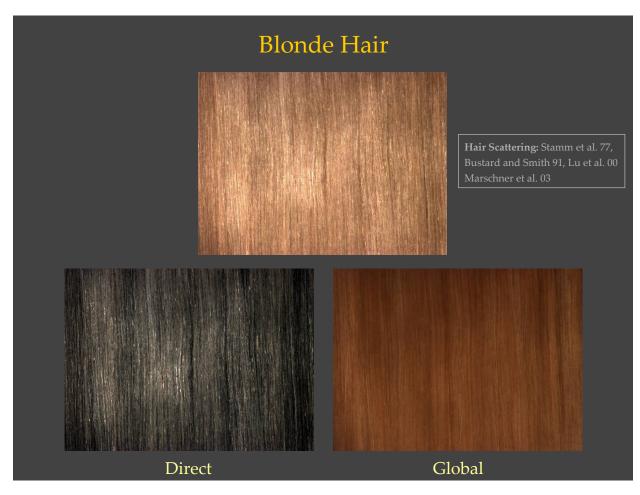


Direct



Global





### Variants of Separation Method

• Coded Structured Light



• Shifted Sinusoids



• Shadow of Line Occluder



• Shadow of Mesh Occluders

### Summary

- Fast and Simple Separation Method
- No Prior Knowledge of Material Properties
- Wide Variety of Global Effects
- Implications:
  - Generation of Novel Images
  - Enhance Computer Vision Methods
  - Insights into Properties of Materials

